## **Physics of Computation**

The processes of drift and diffusion are the stuff of which all information processing devices—both neural and semiconductor—are made.

-Carver Mead (1989)



#### Nernst potential (aka 'reversal potential')

$$V = -\frac{kT}{q} \log \frac{N_{\text{in}}}{N_{\text{ex}}} \quad \text{or} \quad N_{\text{in}} = N_{\text{ex}} e^{-\frac{q}{kT}V}$$

#### **Current-voltage relation of voltage-gated channels**

$$\frac{\theta}{1-\theta} = e^{-E_0/kT} e^{qnV/kT} \qquad \Theta = \text{fraction of channels open}$$

#### **Current-voltage relation of MOS transistor**

$$I = I_0 e^{-\frac{q V_{gs}}{kT}} (1 - e^{\frac{q V_{ds}}{kT}}) \qquad \begin{array}{l} V_{gs} = \text{gate-source voltage} \\ V_{ds} = \text{drain-source voltage} \end{array}$$

All of these things are related by the same fundamental physical law...

#### Its the Boltzmann distribution!

Example: atmospheric pressure vs. elevation

$$v_{\text{drift}} = \frac{wt_f}{2m} = v_{\text{diff}} = -\frac{1}{2N} \frac{dN}{dh} kT \frac{t_f}{m}$$
$$\frac{1}{N} \frac{dN}{dh} kT = -w$$
$$kT \ln \frac{N}{N_0} = -wh$$
$$\text{or, for electric}$$
$$N = N_0 e^{-\frac{wh}{kT}}$$

or, for charge in an electric field:

$$N = N_0 e^{-\frac{q}{kT}V}$$

#### **Active devices**

Voltage-gated channels

MOS transistor

#### **Voltage-gated channels**







$$\frac{N_{\rm o}}{N_{\rm c}} = e^{-E_t/(kT)}$$

$$E_{\rm t} = E_0 - Vnq$$

 $E_t$  = transition energy  $E_0$  = transition energy at V=0

$$\frac{\theta}{1-\theta} = e^{-E_0/(kT)} e^{qnV/(kT)}$$

$$\theta = N_{\rm o}/N$$

## **MOS transistor**



**FIGURE 3.4** Cross-section (a) and energy diagram (b) of an *n*-channel transistor. In a typical 1988 process, the gate-oxide thickness is approximately 400 angstroms (0.04 micron), and the minimum channel length *I* is approximately 1.5 microns. When the circuit is in operation, the drain is biased positively; hence, the barrier for electrons is greater at the drain than at the source. Applying a positive voltage at the gate lowers the electron barrier at both source and drain, allowing electrons to diffuse from source to drain.

$$I = I_0 e^{-\frac{q V_{gs}}{kT}} (1 - e^{\frac{q V_{ds}}{kT}}) \qquad V_{gs} = \text{gate-source voltage} \\ V_{ds} = \text{drain-source voltage}$$



The exponential current-voltage relation in the nerve is a result of the same physical laws responsible for the exponential transistor characteristic. There is an energy barrier between a state in which current can flow and one in which current cannot flow. The height of that barrier is dependent on a control voltage. The Boltzmann distribution determines the fraction of the total population that is in the conducting state. In the transistor, the electrons in the channel form the population in question, and these same electrons carry the current. In the nerve membrane, the channels form the population in question, and ions in the channels carry the current. In both cases, the number of individual charges in transit is exponential in the control voltage, and the transport of these charges results in a current that varies exponentially with the control voltage.

### **Transconductance amplifier**

### **Differential pair**



### **Differential pair**



## **Transconductance** amplifier





## Silicon retina



## HI horizontal cells connected via gap junctions



HI horizontal cells labeled following injection of one HI cell (\*) ×300 after Dacey, Lee, and Stafford, 1996 Hyperpolarization of photoreceptor results in hyperpolarization of horizontal cells



### Hyperpolarization of horizontal cell results in depolarization of photoreceptors



Hyperpolarization of horizontal cell results in depolarization of photoreceptors



Hyperpolarization of horizontal cell spreads to other horizontal cells via gap junctions



Hyperpolarization of horizontal cell spreads to other horizontal cells via gap junctions



Hyperpolarization of horizontal cell spreads to other horizontal cells via gap junctions



## Lateral inhibition



## Lateral inhibition



#### Analog VLSI retina (Mead & Mahowald, 1989)



## "Von Neumann" computing architecture



#### Moore's law is ending



# From: "After Moore's Law," *The Economist*, March 12, 2016

#### Moore's law is ending

## Errors increase as device size decreases



From: Borkar et al. *IEEE Micro* 2005

Analog VLSI (or neuromorphic computing) exploits intrinsic transistor physics and laws of electronics (Kirchhoff's law, Ohm's law) to do computation



## 3D RRAM crossbar array

